


<b>Search Notes</b>  	<b>Application/Control No.</b>  10525021	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAMURA ET AL.
	<b>Examiner</b>  Snigdha Maewall	<b>Art Unit</b>  1612

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventors Search (PALM)	09/11/08	SM
STN	08/07/08	SM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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